

Notice of References Cited

Application/Control No.

09/817,572

Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

2876

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Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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